UC3846 SMPS Controller

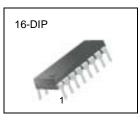
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Features

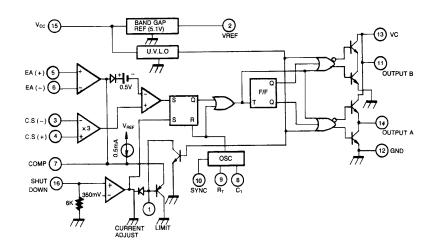
- · Automatic Feed Forward Compensation
- Programmable Pulse by Pulse Current Limiting
- Automatic Symmetry Correction in Push-Pull
- ConfigurationEnhanced Load Response Characteristics
- Parallel Operation Capability for Modulator Power Systems
- Differential Current Sense Amplifier with Common Mode Range
- Double Pulse Suppression
- 200mA Totem-Pole Outputs
- ±2% Band gap Reference
- Under-Voltage Lockout
- Soft-Start Capability
- Shutdown Terminal
- 500KHz Operation

Description

The UC3846 control IC provides all of the necessary features to implement fixed frequency, current mode control schemes while maintaining a minimum external parts count. The superior performance of this technique can be measured in improved line regulation, enhanced load response characteristics, and a simpler, easier-to-design control loop. Topological advantages include inherent pulse-by-pulse current limiting capability, automatic symmetry correction for push-pull converters, and the ability to parallel "power module" while maintaining equal current sharing. Protection circuitry includes built-in-under-voltage lockout and programmable current limit in addition to soft-start capability. A shutdown function is also available which can initiate either a complete shutdown with automatic restart or latch the supply off. Other features include fully latched operation, double pulse suppression, deadtime adjust capability, and $\pm 2\%$ trimmed bandgap reference. The UC3846 features low outputs in the OFF state.



Internal Block Diagram



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Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Supply Voltage	Vcc	40	V
Collector Supply Voltage	Vc	40	V
Output Current, Sink of Source (Peak)	IO	500	mA
Reference Output Current	IREF	30	mA
Soft Start Sink Current	ISINK(S.S)	50	mA
Sync Output Current	ISYNC	5	mA
Error Amplifier Output Current	IO(E.A)	5	mA
Oscillator Changing Current	ICHG(OSC)	5	mA
Power Dissipation ($T_A = 25^{\circ}C$)	PD	1000	mW
Operating Temperature	TOPR	0 ~ +70	°C
Storage Temperature	TSTG	-65 ~ +150	٥°
Lead Temperature (Soldering, 10sec)	TLEAD	+300	۵°

Electrical Characteristics

(V_{CC}=15V, T_A=0°C to +70°C, unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
REFERENCE SECTION						
Reference Output Voltage	Vref	$T_J = 25^{\circ}C$, $I_{REF} = 1mA$	5.00	5.10	5.20	V
Line Regulation	ΔV_{REF}	Vcc = 8 to 40V	-	5	20	mV
Load Regulation	$\Delta VREF$	IREF1 to 10mA	-	3	15	mV
Temperature Stability(Note 6)	STT	-	-	0.4	1.0	mV/°C
Output Voltage Range (Note 6)	VREF	Line,Load,Temp	4.95	-	5.25	V
Short Circuit Output Current	ISC	VREF = 0V	-10	-45	-	mA
Output Noise Voltage(Note 6)	VNO	f = 10Hz to 10KHz, TJ = 25°C	-	100	-	uV
Long-Term Stability(Note 6)	ST	TJ = 125°C, 1KHz	2	5	8	mV

Electrical Characteristics

(V_{CC}=15V,T_A=0°C to +70°C, unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
OSCILLATOR SECTION (Note 2))					
Initial Accuracy	ACCUR	TJ = 25°C	39	43	47	KHz
Frequency Change with Voltage	Δf/ΔVCC	VCC = 8 to 40V	-	1	2	%
Frequency Change with Temperature (Note 6)	$\Delta f/\Delta T$	-	-	1	-	%
Sync Output High Level	VOH(SYNC)	-	3.9	4.35	-	V
Sync Output Low Level	VOL(SYNC)	-	-	2.3	2.5	V
Sync Input High Level	VIH(SYNC)	V8 = 0V	3.9	-	-	V
Sync Input Low Level	VIL(SYNC)	$V_8 = 0V$	-	-	2.5	V
Sync Input Current	II(SYNC)	Sync Voltage = 3.9V, V ₈ = 0V	-	1.3	1.5	mA
ERROR AMPLIFIER SECTION						
Input Offset Voltage	Vio	-	-	0.5	5	mV
Input Bias Current	IBIAS	-	-	-0.6	-1	uA
Input Offset Current	lio	-	-	40	250	uA
Common-Mode Range	VCM	VCC = 8 to 40V	0	-	Vcc2	V
Open Loop Voltage Gain	Gvo	$V_{O} = 1.2$ to 3V, $V_{CM} = 2V$	80	105	-	dB
Unity Gain Bandwidth(Note 6)	BW	$T_J = 25^{\circ}C$	0.7	1.0	-	MHz
Common Mode Rejection Ratio	CMRR	$V_{CM} = 0$ to 38V, $V_{CC} = 40V$	75	100	-	dB
Power Supply Rejection Ratio	PSRR	VCC = 8 to 40V	80	105	-	dB
Output Sink Current	ISINK	$V_{IO} = -15 mV$ to 5V, $V_7 = 2.5V$	2	6	-	mA
Output Source Current	ISOURCE	RL = 15KΩ	-0.4	-0.5	-	mA
High Output Voltage	Voн	RL = 15KΩ	4.3	4.6	-	V
Low Output Voltage	Vol	-	-	0.7	1	V
CURRENT SENSE AMPLIFIER S	ECTION		•	•	•	
Amplifier Gain (Note 1, 3)	Gv	V ₃ = 0V, Pin 1 open	2.5	2.75	3.0	V
Maximum Differential Input Signal (V4 - V3) (Note 1)	VI(DIFF,MAX)	$R_L = 15K\Omega$, Pin 1 open	1.1	1.2	-	V
Input Offset Voltage (Note 1)	Vio	V ₁ = 0.5V, Pin 1 open	-	5	25	mV
Common Mode Rejection Ratio	CMRR	V _{CM} = 1 to 12V	60	83	-	dB
Power Supply Rejection Ratio	PSRR	V _{CC} = 8 to 40V	60	84	-	dB
Input Bias Current (Note 1)	IBIAS	V ₁ = 0.5V, Pin 7 open	-	-2.5	-10	uA
Input Offset Current (Note 1)	lio	V1 = 0.5V, Pin 7 open	-	0.08	1	uA
Delay to Outputs (Note 6)	tD	TJ = 25°C	-	200	500	ns

Electrical Characteristics

(V_{CC}=15V, T_A=0°C to + 70°C, unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit	
CURRENT LIMIT ADJUST SECTION							
Current Limit Offset Voltage (Note 1)	VIO(C.L)	V3 = 0V V4 = 0V, Pin 7 open	0.45	0.5	0.55	V	
Input Bias Current	IBIAS	$V_5 = V_{REF}, V_6 = 0V$	-	- 10	- 30	uA	
SHUTDOWN TERMINAL SECTION							
Threshold Voltage	Vth	-	250	350	400	mV	
Input Voltage Range	VI	-	0	-	Vcc	V	
Minimum Latching Current (Note 4)	I(LATCH,MIN)	-	3.0	1.5	-	mA	
Maximum Non-Latching Current (Note 5)	I(NONLATCH,MAX)	-	-	1.5	0.8	mA	
UNDER-VOLTAGE LOCKOUT SECTION							
Start Threshold	VTH(ST)	-	7	7.7	8.4	V	
Threshold Hysteresis	VHYS	-	0.45	0.75	1.05	V	
OUTPUT SECTION							
Collector-Emitter Voltage	VCEO	-	40	-	-	V	
Collector Leakage Current	ILEAK	VC = 40V	-	-	200	uA	
Low Output Voltage 1	V _{OL} 1	ISINK = 20mA	-	0.1	0.4	V	
Low Output Voltage 2	V _{OL} 2	ISINK = 100mA	-	0.4	2.1	V	
High Output Voltage 1	V _{OH} 1	ISOURCE = 20mA	13	13.5	-	V	
High Output Voltage 2	Voh 2	ISOURCE = 100mA	12	13.5	-	V	
Rise Time (Note 6)	tR	CL = 1nF, TJ = 25°C	-	50	300	us	
Fall Time (Note 6)	tF	CL = 1nF, TJ = 25°C	-	50	300	us	
TOTAL STANDBY CURRENT							
Supply Current	Icc	-	-	17	21	mA	

Notes :

1. Parameter measured at trip point at latch with $V_5 = V_{REF}$, $V_6 = 0V$

2. $R_T = 10K\Omega$, $C_T = 4.7nF$

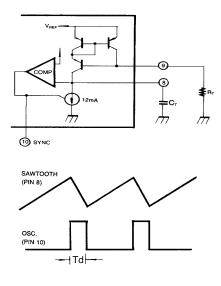
3. Amplifier gain definde as:

$$G = \frac{\Delta V7}{\Delta V4}; \Delta V_4 = 0 to 1.0 V$$

4. Current into Pin 1 guaranteed to latch circuit in shutdown state.

5. Current into Pin 1 guaranteed not to latch circuit in shutdown state.

6. These parameters, although guaranteed over the recommended operating conditions, are not 100% tested in production.



OUTPUT DEADTIME(T_d)

Figure 1. UC3846 Oscillator Circuit

Output deadtime is determined by the external capacitor, C_T , according to the formula: $Td(us) = 145C_T(\mu F)$ For large values of R_T : $T_d(us) = 145C_T(uF)$ Oscillator frequency is approximately

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ight)$$

by the formula: $f_T(KHz) = \frac{2.2}{R_T(K\Omega)C_T(\mu F)}$

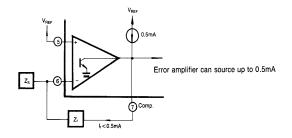


Figure 2. Error Amplifier Output Configuration

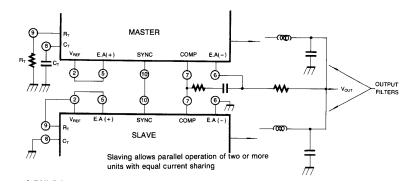


Figure 3. Parallel Operation

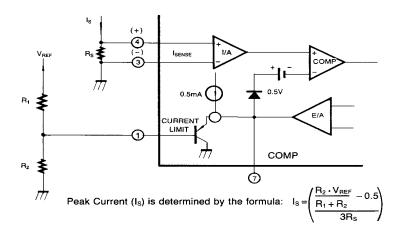


Figure 4. Pulse By Pulse Current Limiting

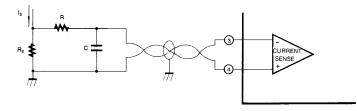
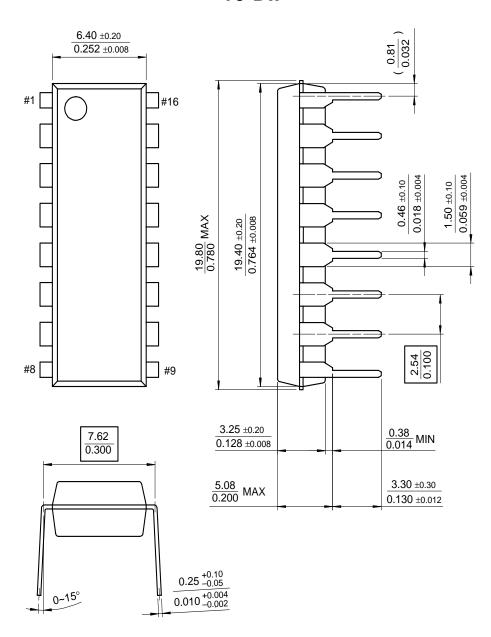


Figure 5. Current Sense Amp Connections

A small PC filter may be required in some applications to reduce switch transients Differential input allows remote, noise free sensing.

Mechanical Dimensions

Package



16-DIP

UC3846

Ordering Information

Product Number	Package	Operating Temperature
UC3846N	16 DIP	0 ~ + 70°C

UC3846

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